**Features:**

- n Low  $V_{CE(sat)}$  trench IGBT technology
- n Low switching losses
- n 10 $\mu$ s short circuit capability
- n  $V_{CE(sat)}$  with positive temperature coefficient

**Typical Applications:**

- n AC inverter drives mains 575-750V AC
- n Public transport (auxiliary syst.)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VALUE			UNIT
			Min	Type	Max	
$V_{CES}$	Collector-Emitter voltage	$T_J=25^\circ\text{C}$			1700	V
$V_{GES}$	Gate-Emitter voltage	$T_J=25^\circ\text{C}$			$\pm 20$	V
$I_C$	Collector current	Continuous@ $T_C=80^\circ\text{C}$			200	A
$I_{CP}$		$T_P=1\text{ms}$			400	A
$P_D$	Maximum Power Dissipation	$T_J=175^\circ\text{C}$ , 1 device			1515	W
$T_J$	Junction temperature	/			175	$^\circ\text{C}$
$T_{stg}$	Storage temperature	/	-40		125	$^\circ\text{C}$
$V_{iso}$	Isolation between terminal and copper base	$T_J=25^\circ\text{C}$ , AC: 1minute	4000			V
Screw torque	Mounting(M6)	/	2.5		5.0	N·m
	Terminals(M6)	/	3.0		5.0	N·m
$I_{CES}$	Zero gate voltage collector current	$T_J=25^\circ\text{C}$ , $V_{CE}=1700\text{V}$ , $V_{GE}=0\text{V}$			3.0	mA
$I_{GES}$	Gate-Emitter leakage current	$T_J=25^\circ\text{C}$ , $V_{CE}=0\text{V}$ , $V_{GE}=\pm 20\text{V}$			$\pm 0.4$	$\mu\text{A}$
$V_{GE(th)}$	Gate-Emitter threshold voltage	$T_J=25^\circ\text{C}$ , $V_{CE}=20\text{V}$ , $I_C=8\text{mA}$	5.2	5.8	6.4	V
$V_{CE(sat)}$	Collector-Emitter saturation voltage	$T_J=25^\circ\text{C}$ , $V_{GE}=15\text{V}$ , $I_C=200\text{A}$		2.0		V
		$T_J=125^\circ\text{C}$ , $V_{GE}=15\text{V}$ , $I_C=200\text{A}$		2.4		V
$R_{Gint}$	Internal gate resistor	$T_J=25^\circ\text{C}$		3.8		$\Omega$
$C_{ies}$	Input capacitance	$T_J=25^\circ\text{C}$ , $V_{CE}=25\text{V}$ , $V_{GE}=0\text{V}$ , $f=1\text{MHz}$		18.0		nF
$C_{res}$	Reverse transfer capacitance			0.60		nF
$t_{on}$	Turn-on time	$T_J=125^\circ\text{C}$ , $V_{CC}=900\text{V}$ , $I_C=200\text{A}$ , $V_{GE}=\pm 15\text{V}$ , $R_g=6.8\Omega$ , Inductive load		310		ns
$t_r$				98		ns
$t_{off}$	Turn-off time			1008		ns
$t_f$				202		ns
$E_{on}$	Turn-on energy loss per pulse			78		mJ
$E_{off}$	Turn-off energy loss per pulse			63		mJ
$I_{sc}$	SC data		$t_{sc} \leq 10 \mu\text{s}$ , $V_{GE}=15\text{V}$ , $T_J=125^\circ\text{C}$ , $V_{CC}=1000\text{V}$ , $V_{CEM} \leq 1700\text{V}$		800	
tsc	Short circuit withstand time	$T_J=125^\circ\text{C}$	10			$\mu\text{s}$

V <sub>F</sub>	Forward on voltage	T <sub>J</sub> =25°C ,I <sub>F</sub> =200A	1.8	V
		T <sub>J</sub> =125°C ,I <sub>F</sub> =200A	1.9	V
I <sub>RM</sub>	Peak reverse recovery current	I <sub>F</sub> =200A, -diF/dt=3600A/μs , V <sub>R</sub> =900V, V <sub>GE</sub> =-15V, T <sub>J</sub> =125°C	231	A
Q <sub>r</sub>	Recovered charge		85.4	μC
E <sub>rec</sub>	Reverse recovery energy		48	mJ
R <sub>th(j-c)</sub>	Thermal resistance(1 device)	IGBT	0.099	°C/W
		FWD	0.19	°C/W
R <sub>th(c-f)</sub>	Contact thermal resistance (1 device)	With thermal compound	0.035	°C/W
W <sub>t</sub>	Weight		310	g
Outline	454H3P			

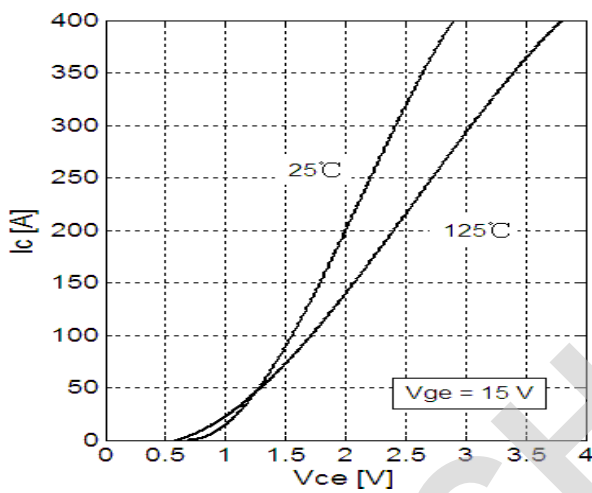


Fig 1. IGBT Typical Output Characteristics

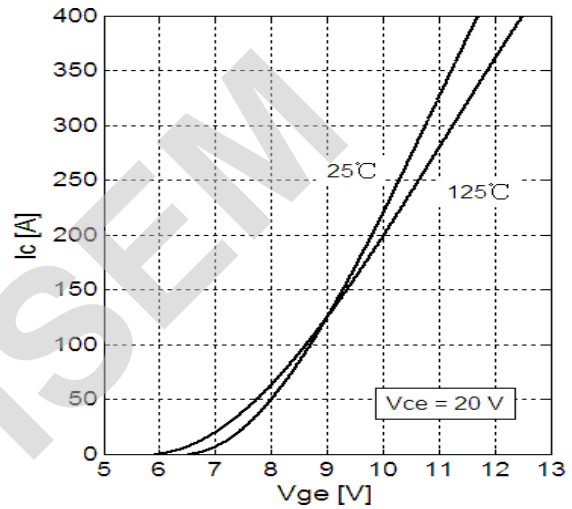


Fig 2. IGBT Typical Transfer Characteristics

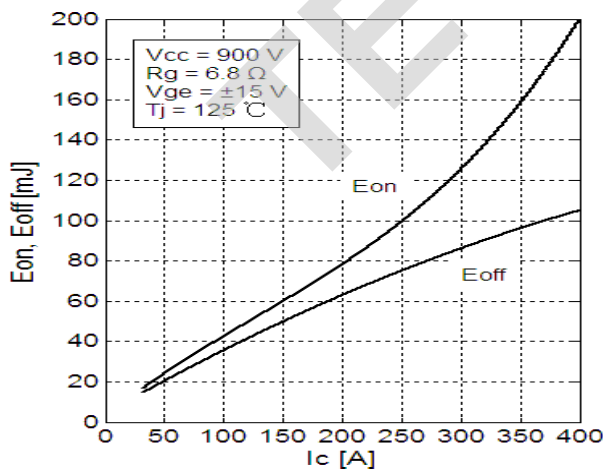


Fig 3. IGBT Switching Loss vs. Collector Current

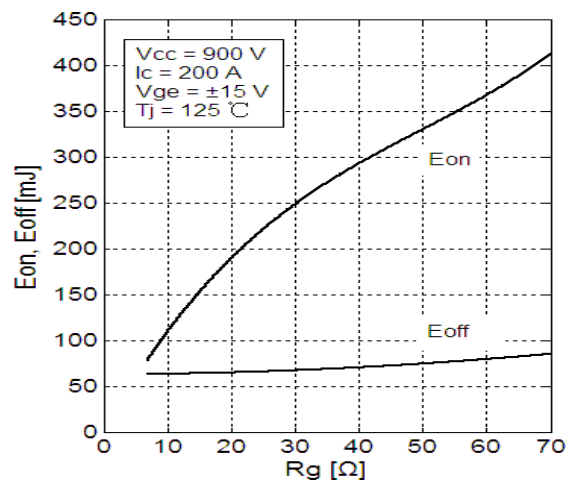


Fig 4. IGBT Switching Loss vs. Gate Resistor

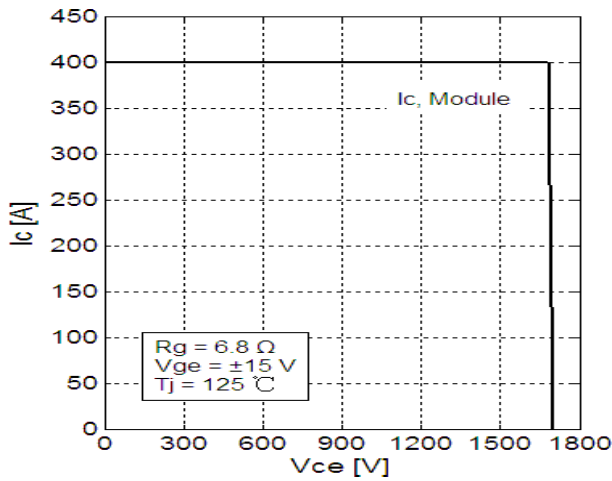


Fig 5. RBSOA

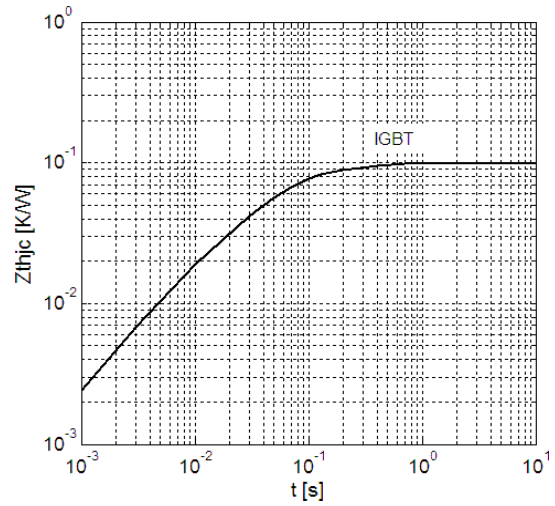


Fig 6. IGBT Transient Thermal Impedance

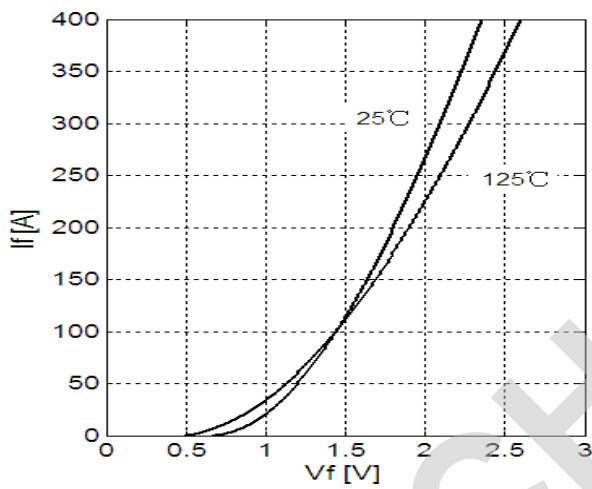


Fig 7. Forward Characteristics of Diode

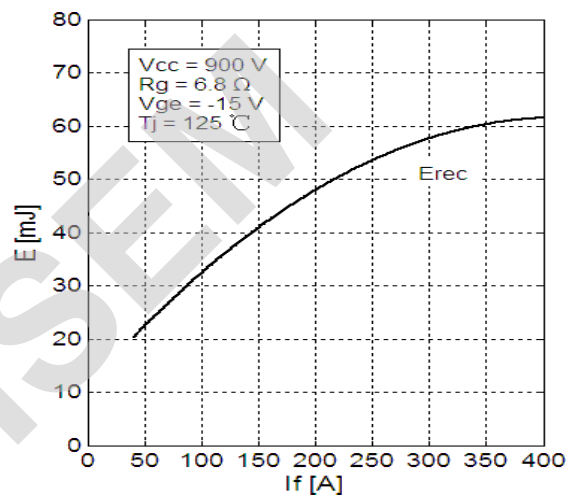


Fig 8. Diode Switching Loss vs. Collector Current

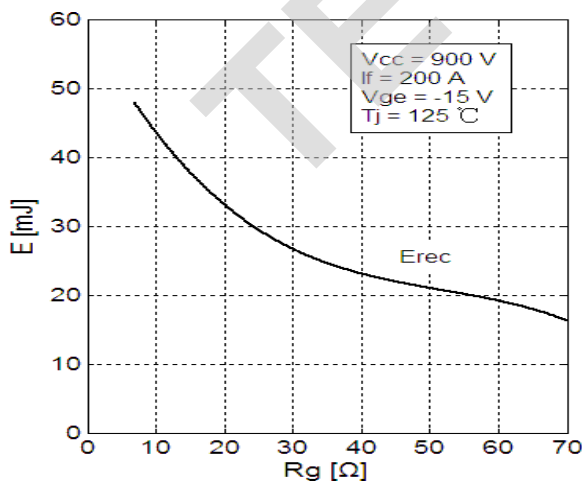


Fig 9. Diode Switching Loss vs. Gate Resistor

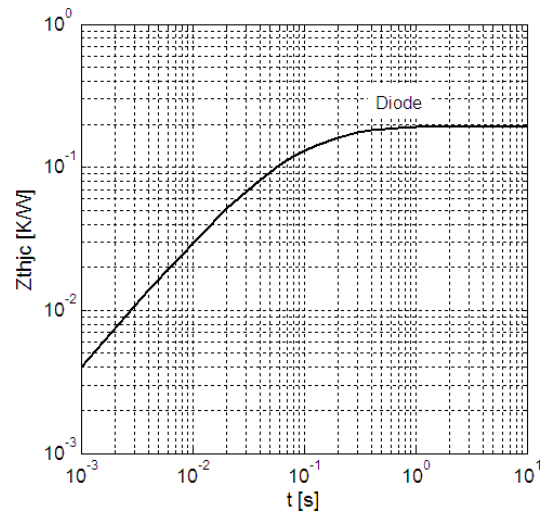
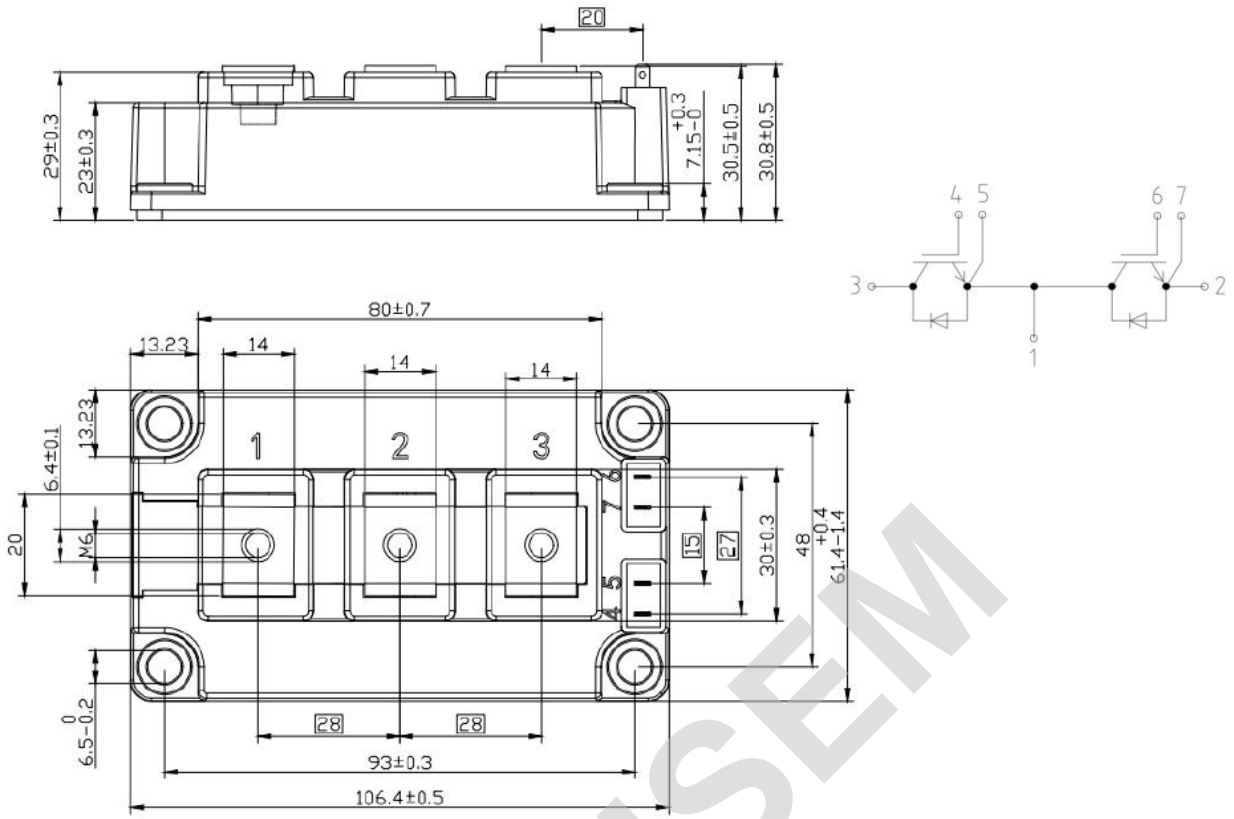


Fig 10. Diode Transient Thermal Impedance

Outline & Circuit Diagram



Unmarked dimensional tolerance: ±0.5mm

TECHSEM reserves the right to change specifications without notice.

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